# Location-Based Technologies and Applications

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## Message from the Guest Editors

This Special Issue will provide an updated overview of location technologies and location-based services, from the analysis, design, and development of solutions to obtain the location of users, to the description and validation of final systems that use these locations to provide advanced services. Topics of interest include, but are not limited to, the following:

- Indoor/outdoor location systems.

- Location in 5G networks.

- Personalization and context-awareness in location-based applications.

- Security, usability, and privacy in location-based systems.

- Human mobility modeling and prediction.

- Use of information from geolocated social networks.

Welcome to contribute.

Special Issue

## Editor-in-Chief

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## Message from the Editor-in-Chief

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